

# Detector Requirements analysis on the Pi-Kaon separation

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# Outline

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- $\triangle$ dEdx,  $\triangle$ TOF, Separation Power and Average Separation Power for  $\pi$ , K
- Impact parameter info for  $\pi, K, p$
- VTX and PID for reconstruction process
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# Introduction

A event in detector: collection of final state particles

A particle: 4 + 3 + 3 variables

- P4:  $(E, p_x, p_y, p_z)$  or  $(E, m, \theta, \varphi)$  ...  $(E^2 = p^2 + m^2)$
- Where it starts: impact parameters, not available for neutrals.
- Where it ends:  $K_s$ ,  $\Lambda$ , B, D ..., only applicable for long lived particles.

To study the fully charged decay process, we need to identify charged Kaon(hadrons) up to 20 GeV. For objects with kaon and/or proton in its decay product:

Performance depends on

- Momentum (fully charged final state)
- Hadron separation, especially  $\pi$ , K separation
- VTX reconstruction. (for heavy flavor hadrons)

#### Introduction



Reconstruction efficiency \* purity vs  $\pi - K$  separation power

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# Introduction

#### - CEPC Baseline Detector Concept



The inner, outer radius and drift length of the TPC( $R_{in}$  and  $R_{out}$ ) are chosen as the boundary conditions to record the time of flight for particles  $\pi$ , k, p.

Preliminary layout of the tracking system of the CEPC baseline detector concept

#### • π \* Κ \_\_\_\_\_\_whi

▲ p

15

20

P/(GeV)

TOF for  $\pi, K, p$ 

10

5

 $\cos\theta = 0.5$ 

10

8

6

TOF/(ns)

The calculation for TOF:

 $t_{total} = \frac{L_{total}}{\beta \gamma c}$ z-direction projection is used to simplify the question.

$$t_z = t_{total} = \frac{\Delta z}{\beta_z \gamma c},$$

where  $\Delta z$  equals to the difference of  $z_{in}$  and  $z_{out}$ , x' which are depended on the inner and outer radius of the TPC( $R_{in}$  and  $R_{out}$ ).



A circular helix of radius R, slope  $\frac{R}{\tan \theta}$  and central axis $(A_x, A_y, z_{const})$  of the particle generation point is described by the following parametrization:

$$\begin{cases} x = R\cos\varphi + A_x, \\ y = R\sin\varphi + A_y, \\ z = \frac{R\varphi}{\tan\theta} + z_{const}, \end{cases}$$
where  $z_{const} = z_0 - R\frac{\varphi_{pca}}{\tan\theta}, \varphi_{pca} = \varphi + \frac{\pi}{2}, A_x = R\cos\varphi - d_0\sin\varphi \text{ and } A_y = R\sin\varphi + d_0\cos\varphi.$ 

Note that if  $\omega > 0$ , then  $\varphi$  in the last equation should reverse sign and  $\varphi_{pca} = \varphi - \frac{\pi}{2}$ .

# dEdx&TOF distribution for $\pi$ , K, p

2 GeV $\cos \theta = 0.5$ 



#### $\Delta$ dEdx & $\Delta$ TOF distribution for $\pi - K$



# Separation Power for $\pi - K$

2 GeV $\cos \theta = 0.5$ 



Separation Power between particle  $\pi$ , *K* is defined as follow:

$$S_{\pi K} = \sqrt{\frac{(I_{\pi} - I_{K})^{2}}{\sigma_{I_{\pi}}^{2} + \sigma_{I_{K}}^{2}}} + \frac{(T_{\pi} - T_{K})^{2}}{\sigma_{T_{\pi}}^{2} + \sigma_{T_{K}}^{2}}$$

where  $I_{\pi}$  ( $I_{K}$ ) and  $\sigma_{I_{\pi}}$  ( $\sigma_{I_{K}}$ ) are the average dE/dx measurement of particle  $\pi(K)$  and the corresponding resolution,  $T_{\pi}$  ( $T_{K}$ ) and  $\sigma_{T_{\pi}}$  ( $\sigma_{T_{K}}$ ) are the average *TOF* measurement of particle  $\pi(K)$ and the corresponding resolution.

In the ideal case assuming no degradation and  $\sigma_I$  and  $\sigma_T$  are in the range of [1 - 5%] and [10 - 80ps] respectively.

 $S_{\pi K}$  is estimated at the CEPC as a function of  $\sigma_I$ ,  $\sigma_T$ , p and  $\cos \theta$ .

 $1-20 \text{ GeV} \\ \cos \theta = 0 - 1$ 



The average separation power  $\langle S \rangle$  versus  $\sigma_I$  and  $\sigma_T$  after integrating over the  $\cos \theta$  and momentum dimension.

$$\langle S_{\pi K}(\sigma_{I}, \sigma_{T}) \rangle = \frac{\int_{0}^{1} \int_{1}^{20} S_{\pi K}(\sigma_{I}, \sigma_{T}, p, \cos \theta) PDF(p, \cos \theta) dp \, d \cos \theta}{\int_{0}^{1} \int_{1}^{20} PDF(p, \cos \theta) dp \, d \cos \theta}$$
The integral form is rewritten into a summation form:
$$\langle S_{\pi K}(\sigma_{I}, \sigma_{T}) \rangle = \frac{\sum \sum S_{\pi K}(\sigma_{I}, \sigma_{T}, p_{i}, \cos \theta_{j}) PDF(p_{i}, \cos \theta_{j}) \Delta p \, \Delta \cos \theta}{\int_{0}^{1} \int_{1}^{20} PDF(p, \cos \theta) dp \, d \cos \theta}$$

 $1-5 \text{ GeV} \\ \cos \theta = 0 - 1$ 

5-10 GeV  $\cos \theta = 0 - 1$ 



10-15 GeV $\cos \theta = 0 - 1$ 

 $15-20 \text{ GeV} \\ \cos \theta = 0 - 1$ 





#### Impact parameter for $\pi, K, p$





Impact parameter is defined as  $\sqrt{\left(\frac{d_0}{\sigma_{d_0}}\right)^2 + \left(\frac{z_0}{\sigma_{z_0}}\right)^2}$ 

 $d_0$  is the distance between the nearest point  $(x_0, y_0, z_0)$  of the track on the  $r - \varphi$  plane and the reference point IP. When  $\underline{d} \times \underline{t}$  and z axis are in the same direction, the sign of  $d_0$  is positive.

# VTX and PID for reconstruction

Selection Process for  $\Lambda \rightarrow p\pi$ :

- 1. Pick two tracks with opposite charges.
- 2. Use truth information to get the track PID.
  - If track PID is lepton, then **end** the process.
  - If track PID is hadron, then use random number generator to mimic PID resolution.
- 3. If the two track PID after step 2 are p and  $\pi$  respectively, then fit the secondary (or tertiary vertex) with two tracks using least square method.
- 4. Select those which satisfy that  $\chi^2$  from the vertex fit has to be under certain threshold (<20).
- 5. Select those which satisfy certain constraints on mass error (<10 MeV). 4-momentum is computed using two tracks at the secondary vertex (or tertiary vertex).
- 6. If the gaussian distributions in this picture is too wide, then most tracks will be identified as  $\pi$ . Then we use the leftover tracks to perform the reconstruction again, this time without PID.

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The scaled spectra of  $(I - I_K)/\sigma_I$  using dE/dx measurements alone for particles with a momentum of 5 GeV/c

# Summary

To identify charged Kaon(hadrons) up to 20 GeV

- VXT:  $\chi^2$ , reconstructed parent mass and impact parament

$$\left(\frac{d_0}{\sigma_{d_0}}\right)^2 + \left(\frac{z_0}{\sigma_{z_0}}\right)^2$$

- PID: dE/dx and TOF

Preliminary:

-  $3\sigma$  separation of  $\pi - K$ , corresponding to 3.2 % of dE/dx resolution and  $50 \, ps$  TOF resolution, is appreciated.

Next:

- The impact parament will be used to optimize the reconstruction process

## Check Validity

